



AP / 2876
PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: S. Krishnaswamy, et al.

Serial No: 09/363,728

Filed: July 29, 1999

For: ANALYTE TEST INSTRUMENT
SYSTEM INCLUDING DATA MANAGEMENT
SYSTEM

Examiner: Le, Uyen Chau N

Case No.: 6401.US.O1

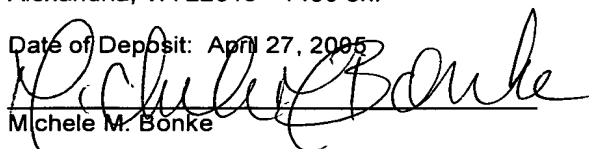
Group Art Unit: 2876

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MS Amendment
Commissioner for Patents
P.O. Box 1450
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Michele M. Bonke

TRANSMITTAL LETTER

MS Amendment
Commissioner for Patents
Alexandria, VA 22313 - 1450

Dear Sir:

Enclosed herewith for the patent application identified above entitled
ANALYTE TEST INSTRUMENT SYSTEM INCLUDING DATA MANAGEMENT
SYSTEM are the following:


1. Information Disclosure Statement
2. PTO Form 1449
3. Copies of Two EPC Search Reports
4. Copies of Seven References Cited
5. Return Receipt Postcard

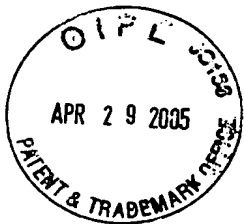
The Commissioner is hereby authorized to charge any additional Filing Fees required under 37 CFR §1.16, as well as any patent application processing fees under 37 CFR §1.17 associated with this communication for which full payment had not been tendered, to Deposit Account No. 01-0025.

Respectfully submitted,
S. Krishnaswamy, et al.

23492

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PATENT

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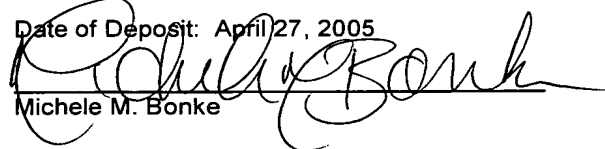
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Michele M. Bonke

INFORMATION DISCLOSURE STATEMENT (SUPPLEMENTAL)

Commissioner for Patents
Alexandria, VA 22313-1450

Dear Sir:

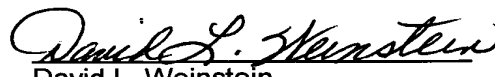
This statement is being sent to disclose information related to the above-identified application. The references are listed on USPTO Form 1449, two copies of which are attached. The references were located in searches conducted by the European Patent Office. Copies of the cited references (7) and copies of the European Search Reports (2) are also attached. Review is respectfully requested, and the Examiner is asked to place his/her initials next to each reference listed on the form to indicate that the reference was considered and return one copy to us.

The undersigned certifies that each item of information contained in the Information Disclosure Statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the information disclosure statement. Therefore, no fee is required.

Respectfully submitted,
S. Krishnaswamy, et al.

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Attorney for Applicants

Form PTO - 1449 (Modified)

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE
(Modified) PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.

SERIAL NO.

6401USO1

09/363,728

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT

APPLICANT

S. Krishnaswamy, et al.

(Use several sheets if necessary)

(37 CFR 1.98 (b))

FILING DATE

GROUP

07/29/1999

2876

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A1	5,307,263	04/26/1994	Brown			

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NUMBER	PUBLIC- ATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANS- LATION	
							YES	NO
	B1	0 251 520	07.01.88	EP				X
	B2	0 290 683	17.11.88	EP				X
	B3	0 387 630	19.09.90	EP				X
	B4	0 684 575	29.11.95	EP				X
	B5	43 15 532	18.11.93	DE				X
	B6	94/11838	26.05.94	WO				X

OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication)

	C1		Two Copies of The EPC Search Report

EXAMINER

DATE CONSIDERED

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

(Form PTO-1449)